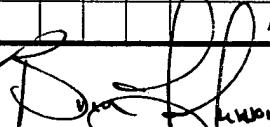
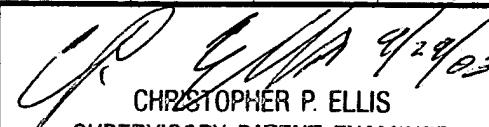
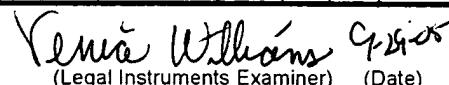


Issue Classification				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/632,896	CHANG, JEN-SHOW	
				Examiner	Art Unit	
				Brian Swenson	3618	

ORIGINAL				CROSS REFERENCE(S)								
CLASS		SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
280		87.042	280	11.203								
INTERNATIONAL CLASSIFICATION												
B	6	2	M	1/00								
				/								
				/								
				/								
				/								
 Brian Swenson 9/28/05 (Assistant Examiner) (Date)				 CHRISTOPHER P. ELLIS 9/28/05 SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3600 (Primary Examiner) (Date)							Total Claims Allowed: 3	
 Venia Williams CP-2605 (Legal Instruments Examiner) (Date)											O.G. Print Claim(s) 1	O.G. Print Fig. 1,7

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		121
2	2		32		62		122
3	3		33		63		123
4			34		64		124
5			35		65		125
6			36		66		126
7			37		67		127
8			38		68		128
9			39		69		129
10			40		70		130
11			41		71		131
12			42		72		132
13			43		73		133
14			44		74		134
15			45		75		135
16			46		76		136
17			47		77		137
18			48		78		138
19			49		79		139
20			50		80		140
21			51		81		141
22			52		82		142
23			53		83		143
24			54		84		144
25			55		85		145
26			56		86		146
27			57		87		147
28			58		88		148
29			59		89		149
30			60		90		150